

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,496	AHMED ET AL.	
Examiner	Art Unit	
MICHAEL Y. WON	2155	

SEARCHED					
Class	Subclass	Date	Examiner		
709	230	2/26/2008	MW		
710	11, 105, 315	2/26/2008	MW		
719	326	2/26/2008 .	MW		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
709	230	2/26/2008	MW		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	2/26/2008	MW		
NPL SEARCH: IEEE	2/26/2008	MW		
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